

SHEET 1 OF 1

**INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION**

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APPLICANT
Saichirou KANEKO, et al.

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FILING DATE
February 06, 2004

GROUP

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS

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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
<i>AT</i>		Yi. Tang et al., "IMPROVEMENT AND ANALYSIS OF IMPLANTED-EMITTER BIPOLAR JUNCTION TRANSISTORS IN 4H-SIC", Materials Science Forum Vols. 389-393 (2002), pp. 1329-1332

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